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Substitute for form 1449A/B/PTO

INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(Use as many sheets as necessary)

Sheet 1 of 1

Complete if Known	
Application Number	10/677,955
Filing Date	October 2, 2003
First Named Inventor	Akio Ohba
Art Unit	2186
Examiner Name	~~Not Yet Assigned~~ Elmore
Attorney Docket Number	SCEI 3.0-038 CONT

U.S. PATENT DOCUMENTS

Examiner Initials*	Cite No.[1]	Document Number Number-Kind Code[2] (*if known*)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear

FOREIGN PATENT DOCUMENTS

Examiner Initials*	Cite No.[1]	Foreign Patent Document Country Code[3]-Number[4]-Kind Code[5] (*if known*)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T[6]
SE	BA	JP-04-277857-A1	10-02-1992	NEC Corp		**

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. [1] Applicant's unique citation designation number (optional). [2] See Kinds Codes of USPTO Patent Documents at www.uspto.gov or MPEP 901.04. [3] Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). [4] For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. [5] Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. [6] Applicant is to place a check mark here if English language Translation is attached.

NON PATENT LITERATURE DOCUMENTS

Examiner Initials*	Cite No.[1]	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T[2]

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** with English abstract only.

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Examiner Signature	SCElmore	Date Considered	11-23-2004

Filed 10-2-2003 SCE

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Examiner Name	~~Not Yet Assigned~~ Elmore
Attorney Docket Number	SCEI 3.0-038 CONT

U.S. PATENT DOCUMENTS

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SE	AA	US-4,891,751	01/1990	Call et al.	
SE	AB	US-4,975,843	12/1990	Brunnett et al.	
SE	AC	US-5,038,386	08/1991	Li	
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SE	CA	Sanguinetti, "Micro-Analysis of the Titan's Operational Pipe," pp 190-196, ACM, 1988.	
SE	CB	Sato et al., "Fast Image Generation of Constructive Solid Geometry Using A Cellular Array Processor," pp 92-102, ACM, 1985.	
SE	CC	Fuchs et al., "Pixel-Planes 5: A Heterogeneous Multiprocessor Graphics System Using Processor-Enhanced Memories," pp 79-88, ACM, 1989.	
SE	CD	Bajwa et al., "A Massively Parallel, Micro-grained VLSI Architecture," pp 250-255, 1994.	
SE	CE	M. Auguin et al., "Parallel Memory Management in a SIMD Computer", Highly Parallel Computers. Proceedings of the IFIP WG 10.3 Working Conference on Highly Parallel Computers for Numerical and Signal Processing Applications, Sophia Antipolis, France, March 24-26, 1986, pp 97-110.	

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Examiner Signature	S. Elmore	Date Considered	11-23-2004